



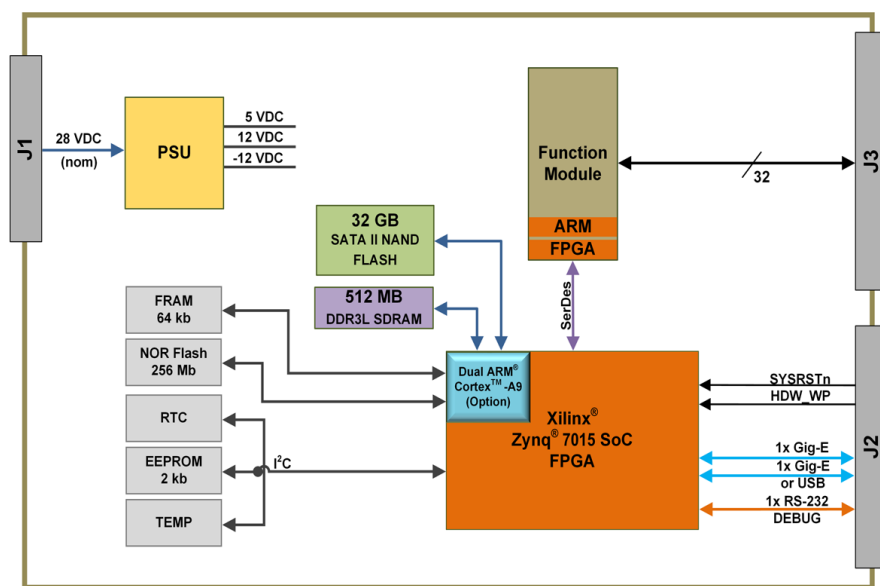
NIU1A Rugged COTS Systems

Nano Interface Unit

**Configure with one I/O or communication function module—
Over 100 different modules to choose from**

NIU1A contains an integrated power supply, one function module slot, and an optional ARM® Cortex®-A9 processor. This small, low-power unit is ideally suited for rugged military, industrial, and commercial applications. It delivers off-the-shelf solutions that accelerate deployment of SWaP-optimized systems — *in less time, with NO NRE*.

The NIU1A includes BSP and SSK support for Wind River® Linux and VxWorks®, and for Xilinx® Petalinux (w/optional ARM Processor). In addition, SSKs are supplied with source code and board-specific library I/O APIs to facilitate system integration.



Features

- **Supports one NAI smart I/O function module**
 - 100+ modules to choose from
 - Customer-configurable
 - COSA® architecture
- **Minimized SWaP Footprint**
 - 6.8" x 1.6" x 2.5" (incl. connectors)
 - ~1.2 lbs. (544 g)
 - 28 VDC Input
 - <5 W MB power dissipation
- **Optional ARM® Cortex® - A9 Dual Core 800MHz Processor**
- **152 MB DDR3 SDRAM**
- **32 GB (max) SATA II NAND Flash**
- **Connectivity**
 - 2x 10/100/1000 Base-T Ethernet or 1x 10/100/1000 Base-T Ethernet and USB
 - 1x RS-232
- **Continuous Background BIT**
- **VICTORY Interface Services (Contact factory)**
- **Operating System Support**
 - Xilinx Petalinux
 - Wind River® Linux
 - VxWorks®
- **Commercial and Rugged applications***
 - MIL-STD-704F
 - MIL-STD-461
 - Operating temp: -40°C to +71°C

*Designed to meet. Characterizations pending. EMI/EMC requires shielded cables and proper grounding practices.

Select 1 independent function for your application

| I/O Modules | | | | | |
|---|------------|--|---|------------|--|
| Function | Module | Description | Function | Module | Description |
| Analog-to-Digital | <u>AD1</u> | 12 CH. A/D, ±10 V, Dedicated, 256 kHz (max), Sigma-Delta | Digital IO - Differential Transceiver | <u>DF1</u> | 16 CH. Differential I/O, Input: -10 V to +10 V (422), -7 V to +12 V (485) Output: -.25 V to +5 V |
| | <u>AD2</u> | 12 CH. A/D, ±100 V (max), Dedicated, 256 kHz (max), Sigma-Delta | | <u>DF2</u> | 16 CH. 16 Channel Enhanced Differential I/O |
| | <u>AD3</u> | 12 CH. A/D, ±25 mA, Dedicated, 256 kHz (max), Sigma-Delta | Discrete IO - Multichannel,Programmable | <u>DT1</u> | 24 CH. Discrete I/O, 0-60 VDC Input/Output, Max Iout 500 mA - 2 A, Source/Sink (out) |
| | <u>AD4</u> | 16 CH. A/D, ± 10 V, Multiplexed, 500 KHz Agg / 8 Ch, SAR | | <u>DT2</u> | 16 CH. Discrete I/O, ±80 V Input/Output, Max Iout 600 mA, Isolated/Ch Switch (out) |
| | <u>AD5</u> | 16 CH. A/D, ± 50 V, Multiplexed, 500 KHz Agg / 8 Ch, SAR | | <u>DT4</u> | 24 CH. Enhanced DT1 |
| | <u>AD6</u> | 16 CH. A/D, ± 100 V, Multiplexed, 500 KHz Agg / 8 Ch, SAR | | <u>DT5</u> | 16 CH. Enhanced DT2 |
| | <u>ADE</u> | 16 CH. A/D, ±10 V, Individual 16-bit SAR, 200 kHz max., Simultaneous Sampling | Relay | <u>RY1</u> | 4 CH. Relay, 220V/2A @ 60W/62.5VA (Max), Non Latching |
| | <u>ADF</u> | 16 CH. A/D, ±100 V, Individual 16-bit SAR, 200 kHz max., Simultaneous Sampling | | <u>RY2</u> | 4 CH. Relay, 220V/2A @ 60W/62.5VA (Max), Latching |
| | <u>ADG</u> | 16 CH. A/D, ±25 mA, Individual 16-bit SAR, 200 kHz max., Simultaneous Sampling | Digital IO - TTL,CMOS | <u>TL1</u> | 24 CH. TTL I/O, Standard Functionality, Programmable |
| Digital-to-Analog | <u>DA1</u> | 12 CH. D/A, ± 10 V, 25 mA Per Channel, Current or Voltage Control | | <u>TL2</u> | 24 CH. TTL I/O, Enhanced Functionality, Programmable |
| | <u>DA2</u> | 16 CH. D/A, ± 10 V, 10 mA Per Channel, No Current Control | Variable Reluctance | <u>VR1</u> | 8 CH. Variable Reluctance Signal Input and General-Purpose Pulse Counter, ±100 V, 100 kHz (max) |
| | <u>DA3</u> | 4 CH. D/A, ±40 V, ±100 mA, Voltage or Current Output | | | |
| Measurement & Simulation Modules | | | | | |
| Function | Module | Description | Function | Module | Description |
| AC Reference | <u>AC2</u> | 2 CH. AC Reference Source, 47 Hz - 20 KHz, ± 3% Acc, 2 – 28 Vrms, 6 VA (Max/Ch) Power | LVDT RVDT Measurement and Simulation | <u>LD3</u> | 4 CH. LVDT/RVDT to Digital, 2-28 Vrms Input, 2-115 Vrms Exc, 5 KHz - 10 KHz Freq |
| | <u>AC3</u> | 2 CH. AC Reference Source, 47 Hz - 2.5 KHz, ± 3% Acc, 28 – 115 Vrms, 6 VA (Max/Ch) Power | | <u>LD4</u> | 4 CH. LVDT/RVDT to Digital, 2-28 Vrms Input, 2-115 Vrms Exc, 10 KHz - 20 KHz Freq |
| Synchro Resolver Measurement and Simulation | <u>DSK</u> | 3 CH. Digital to Synchro, 2-28 VLL, 2-115 Vrms Exc, 1 KHz - 5 KHz Freq, .5 VA/Ch (Max) | | <u>LD5</u> | 4 CH. LVDT/RVDT to Digital, 28-90 Vrms Input, 2-115 Vrms Exc, 47 Hz - 1 KHz Freq |
| LVDT RVDT Measurement and Simulation | <u>LD1</u> | 4 CH. LVDT/RVDT to Digital, 2-28 Vrms Input, 2-115 Vrms Exc, 47 Hz -1 KHz Freq | Thermocouple and RTD Measurement | <u>RT1</u> | 8 CH. Resistance Temperature Detectors (RTD), 2, 3, or 4 wire, 16 Bit Res, 16.7 Hz/Ch |
| | <u>LD2</u> | 4 CH. LVDT/RVDT to Digital, 2-28 Vrms Input, 2-115 Vrms Exc, 1 KHz - 5 KHz Freq | | <u>TC1</u> | 8 CH. Thermocouple, 4.17 - 470 Hz, ±100 mV A/D |

| Communication Modules | | | | | |
|------------------------------|------------|--|------------------------------|------------|--|
| Function | Module | Description | Function | Module | Description |
| ARINC Communications | <u>AR1</u> | 12 CH. ARINC 429, 100 KHz or 12.5 KHz, RX/TX, 256 Word Tx/Rx Buffer | MIL-STD-1553B | <u>FTE</u> | 2 CH. MIL-STD-1553 (AMC), BC, RT, BM, BM/RT, 128 KB RAM Per Channel, Direct Coupled |
| | <u>AR2</u> | 1 CH. ARINC 568 (CH-1, RX & TX) & 1 Channel ARINC 579 (CH-2, Programmable RX or TX), 1024-Word TX & RX Buffers per Ch. | | <u>FTF</u> | 4 CH. MIL-STD-1553 (AMC), BC, RT, BM, BM/RT, 128 KB RAM Per Channel, Direct Coupled |
| CANBus Communications | <u>CB1</u> | 8 CH. CANBus, CAN 2.0 A/B, 16 K RX/TX Buffer, 1 Mb/s Max Data Rate | MIL-STD-1760 | <u>FTJ</u> | 1 CH. MIL-STD-1760 (1553), BC, RT, BM, BM/RT, 128 KB RAM, Transformer Coupled |
| | <u>CB2</u> | 8 CH. CANBus, J1939, 16 K RX/TX Buffer, 500 kb/s Max Data Rate | | <u>FTK</u> | 2 CH. MIL-STD-1760 (1553), BC, RT, BM, BM/RT, 128 KB RAM Per Channel, Transformer Coupled |
| | <u>CB3</u> | 8 CH. CANBus, CAN 2.0 A/B (CB1) or J1939 (CB2) protocol layer programmable per channel | Serial Communications | <u>SC1</u> | 4 CH. Serial, RS-232/422/423 (MIL-STD-188C)/485, Non Isolated |
| MIL-STD-1553B | <u>FTA</u> | 1 CH. MIL-STD-1553 (AMC), BC, RT, BM, BM/RT, 128 KB RAM, Transformer Coupled | | <u>SC3</u> | 8 CH. (max) RS-232/422/485 Serial Communications or GPIO, Programmable, Non-isolated |
| | <u>FTB</u> | 2 CH. MIL-STD-1553 (AMC), BC, RT, BM, BM/RT, 128 KB RAM Per Channel, Transformer Coupled | | <u>SC5</u> | 4 CH. RS-232/422/485 communications, isolated per channel and from SYS GND |
| | <u>FTC</u> | 4 CH. MIL-STD-1553 (AMC), BC, RT, BM, BM/RT, 128 KB RAM Per Channel, Transformer Coupled | | <u>SC6</u> | 4 CH. RS-232/422/485 communications, individual SYS GND provided per channel (non-isolated) |
| | <u>FTD</u> | 1 CH. MIL-STD-1553 (AMC), BC, RT, BM, BM/RT, 128 KB RAM, Direct Coupled | | | |
| Storage | | | | | |
| Function | Module | Description | Function | Module | Description |
| SATA Solid State Drive (SSD) | <u>FM2</u> | 1 CH. 480 GB MLC SATA Flash, extended temp -40°C to 85°C operation | SATA Solid State Drive (SSD) | <u>FM9</u> | 1 CH. 1.92 TB SATA TLC NAND Flash, Extended Temperature Operation |
| | <u>FM8</u> | 1 CH. 1 TB SATA TLC NAND Flash, Extended Temperature Operation | | | |
| Combination Modules | | | | | |
| Function | Module | Description | Function | Module | Description |
| Combo | <u>CM5</u> | 2 CH. Dual-redundant MIL-STD-1553 & 8 Channel ARINC 429/575, 100 KHz or 12.5 KHz, RX or TX, 256 Word Tx/Rx Buffer | Combo | <u>CM8</u> | 2 CH. Dual-redundant MIL-STD-1553 & 12 Channel Discrete I/O, 0-60 VDC Input/Output, Max Iout 500 mA - 2 A, Source/Sink (out) |

Board Support Package and Software Support

The NIU1A includes BSP and SDK support for Wind River® VxWorks® / Linux and Xilinx® PetaLinux tools. In addition, software support kits are supplied, with source code and board-specific library I/O APIs, to facilitate system integration. Each I/O function has dedicated processing, unburdening the SBC from unnecessary data management overhead.

Background Built-In-Test (BIT)

BIT continuously monitors the status of all I/O during normal operations and is totally transparent to the user. SBC resources are not consumed while executing BIT routines. This simplifies maintenance, assures operational readiness, reduces life-cycle costs and— keeps your systems mission ready.

Architected for Versatility

NAI's Configurable Open Systems Architecture™ (COSA®) offers a choice of over 100 smart I/O, communications, or Ethernet switch functions, providing the highest packaging density and greatest flexibility of ruggedized embedded product solutions in the industry. Preexisting, fully-tested functions can be combined in an unlimited number of ways quickly and easily.

One-Source Efficiencies

Eliminate man-months of integration with a configured, field-proven system from NAI. Specification to deployment is a seamless experience as all design, state-of-the-art manufacturing, assembly and test are performed - by one trusted source. All facilities are located within the U.S. and optimized for high-mix/low volume production runs and extended lifecycle support.

Product Lifecycle Management

From design to production and beyond, NAI's product lifecycle management strategy ensures the long-term availability of COTS products through configuration management, technology refresh and obsolescence component purchase and storage.

All specifications are subject to change without notice. All product and company names are trademarks or registered trademarks of their respective holders

